

**Search Notes**

Application No.

09/739,582

Examiner

Chris C. Chu

Applicant(s)

TEIG ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	776, 773, 786, 758, and 700	11/8/2004	C.C.
716	2,5&7-12	11/8/2004	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
As same	as above	11/8/2004	C.C.

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in USPAT; US-PGPUB; EPO; JPO; DERWENT; and IBM_TDB;	11/8/2004	C.C.